



# Effect of deposition parameters on micro- and nano-crystalline diamond films growth on WC–Co substrates by HFCVD

Jian-guo ZHANG, Xin-chang WANG, Bin SHEN, Fang-hong SUN

School of Mechanical Engineering, Shanghai Jiao Tong University, Shanghai 200240, China

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**Abstract:** The characteristics of hot filament chemical vapor deposition (HFCVD) diamond films are significantly influenced by the deposition parameters, such as the substrate temperature, total pressure and carbon concentration. Orthogonal experiments were introduced to study the comprehensive effects of such three parameters on diamond films deposited on WC–Co substrates. Field emission scanning electron microscopy, atomic force microscopy and Raman spectrum were employed to analyze the morphology, growth rate and composition of as-deposited diamond films. The morphology varies from pyramidal to cluster features with temperature decreasing. It is found that the low total pressure is suitable for nano-crystalline diamond films growth. Moreover, the substrate temperature and total pressure have combined influence on the growth rate of the diamond films.

**Key words:** hot filament chemical vapor deposition (HFCVD); diamond films; WC–Co substrates; deposition parameters

## 1 Introduction

Diamond films have received intensively investigations as protecting coatings due to their attractive properties such as high hardness, good wear resistant, low friction coefficient and favorable chemical inertness [1–3]. Hot filament chemical vapor deposition (HFCVD) method is widely used for depositing diamond films because of its geometry simplicity and comparative low cost. The parameters, such as substrate temperature ( $t$ ), total pressure ( $p$ ) and carbon content ( $x$ ), are the main parameters that govern the growth process and the quality of as-deposited diamond films [4]. Some investigations on the effects of the parameters on CVD diamond films growth have been reported in available literatures.

ALI and ÜRGEN [5] investigated the effect of a wide range of methane concentrations from 0.5% to 3.5% (volume fraction) on surface morphology, growth rate and quality of diamond films. They concluded that with an increasing  $\text{CH}_4$  volume fraction, the diamond cluster decreased but the growth rate increased. Besides, the favorable polycrystalline orient (220) could be obtained at 2.5% and 3.0%  $\text{CH}_4$ . The effects of  $\text{CH}_4$  concentration on diamond films grown on Si substrates

were also studied by other researchers; they revealed that the non-diamond carbon and growth rate are enhanced by increasing the  $\text{CH}_4$  concentration [6,7]. Besides, TAHER et al [8] compared physical properties of diamond coatings on WC–Co tool inserts with different  $\text{CH}_4$  concentrations and achieved the optimal parameters with  $\text{CH}_4$  concentration ranging from 1% to 3%. FABISIAK et al [9] studied the effect of the total gas pressure in the range of 2.0–12.0 kPa on diamond films growth on silicon wafers, showing that well-defined (100) crystal planes indicating high-quality diamond films are obtained at 8 kPa. YU and FLODSTRÖM [10] also studied the effect of pressure on surface morphologies and crystal orientations of diamond films, demonstrating that the low pressure (650 Pa) was favorable for (111) facets growth and high pressure (2.6 kPa) was beneficial of (100) facets growth. KOBAYASHI et al [11] synthesized different diamond films with the pressure varying from 5 to 160 kPa (atmospheric pressure). The results indicated that the higher quality and growth rate of diamond films were obtained at atmospheric pressure. WEI et al [12] studied the effect of temperature on nano-crystalline diamond films on WC–13% Co (mass fraction) substrates and found that higher temperature is in favor of promoting the diamond nucleation and improving the adhesive strength between diamond films

and substrates. Moreover, they also studied the effect of the filament–substrate separation on diamond growth on WC–Co bar substrates, proving that the growth rate, film quality and surface morphology are all sensitive to the filament–substrate separation [13]. Besides, the incorporation of dopants, such as oxygen, nitrogen and argon, also affects the characterization of as-fabricated CVD diamond films [14–18].

What's more, deposition parameters are interdependent on the characterization of as-deposited diamond films. SALGUEIREDO et al [19] adopted a Taguchi matrix to design the experiments, with the purpose of studying the comprehensive effects of several key deposition parameters on diamond films growth on SiC substrates, including the gas composition, total gas pressure, total mass flow and substrate temperature. HUNG and SHIH [20] studied the effects of various control factors on the performance of microwave plasma enhanced CVD (MPECVD) diamond films, concluding that the bias voltage, methane concentration and hydrogen flow rate are the most important influencing factors on the quality of MPECVD diamond films. MALLIKA and KOMANDURI [21] investigated the effects of the chamber pressure, substrate temperature, microwave power and  $\text{CH}_4$  concentration on diamond films growth on silicon nitride cutting tools and found the optimum deposition conditions for producing high-quality diamond coatings. However, most of the researchers focused on the diamond films grown on the Si-related substrates. Moreover, the combined effects of the total pressure, substrate temperature and carbon content on diamond deposition on WC–Co substrates are rarely investigated.

In the present work, in order to investigate the mutual effects of the parameters on diamond films deposition on WC–Co substrates, the orthogonal experiment method is adopted. The effects of various deposition parameters on the surface morphology, growth rate and chemical structure of as-deposited diamond films are studied with the field emission scanning electron microscope (FE-SEM), atomic force microscope (AFM) and Raman spectrum. Furthermore, the adhesive strength between the film and substrate is also evaluated by Rockwell indentation tests. The results of this study are expected to provide helpful guidance for fabricating high-quality diamond coated WC–Co tools with complex geometries.

## 2 Experimental

The WC–6%Co inserts with dimensions of 13 mm×13 mm×4 mm were used as the substrates. Prior to the deposition process, the WC–Co inserts were pretreated by a two-step chemical etching method. Firstly,

the WC–Co inserts were dipped in the Murakami's reagent of 10 g  $\text{K}_3\text{Fe}(\text{CN})_6$  + 10 g KOH + 100 mL  $\text{H}_2\text{O}$  in an ultrasonic vessel for 30 min. The second etching step was performed using acid solution of 20 mL HCl + 80 mL  $\text{H}_2\text{O}_2$  to etch the cobalt on the surfaces. Subsequently, the inserts were ground with 5  $\mu\text{m}$  diamond powders and then cleaned ultrasonically with acetone for 5 min. Tantalum wires ( $d=0.5$  mm) were used as hot filaments, which were dragged to be straight and fixed above the substrates, as shown in Fig. 1. In order to obtain uniform substrate temperature distribution, the filaments were arranged in parallel and equidistance manner displayed in Fig. 1(b), in which the filament–substrate separation ( $H$ ) was defined as the distance between the top of substrate and the horizontal plane of filaments. During the deposition process, the substrate temperature was changed by adjusting  $H$ . A temperature measuring system was adopted to monitor the substrate temperature during the deposition process. During the deposition process, when the filament power reached  $(2000\pm5)$  W, the average temperatures were 930, 810 and 650 °C according to  $H=5, 10$  and 15 mm, respectively.

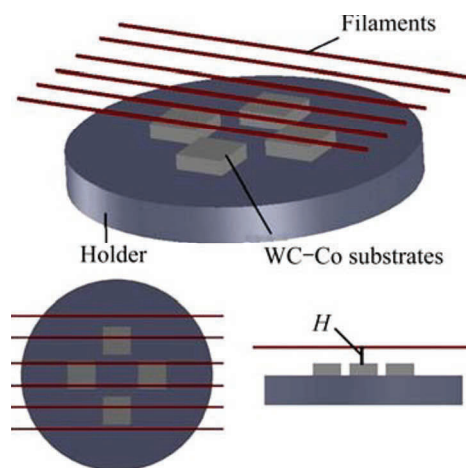


Fig. 1 Schematic diagram of filament–substrate system

The deposition experiments were developed from the theory of orthogonal design to study three variables at three levels each based on the Taguchi method [22]. The three chosen variables were: substrate temperature, total pressure and carbon content (the volume ratio of acetone gas to hydrogen). This design permitted the determination of the relative importance of each variable on the diamond films' characteristics. In this study, such the three variables were identified and observed in an  $L(3\times3)$  orthogonal array experiment with three levels, as shown in Table 1.

As-fabricated diamond films with different parameters were characterized with the field emission scanning electron microscope (FE-SEM, Zeiss ULTRA55), atomic force microscope (AFM, NanoScope IIIa) and Raman spectroscopy (SPEX1403) equipped

**Table 1** Experimental layout using  $L(3 \times 3)$  orthogonal array

Sample No.	$t/^{\circ}\text{C}$	$p/\text{kPa}$	$x/\%$
A	930±10	1.3	2.5
B	930±10	3.9	3.5
C	930±10	5.2	5.0
D	810±10	1.3	3.5
E	810±10	3.9	5.0
F	810±10	5.2	2.5
G	650±10	1.3	5.0
H	650±10	3.9	2.5
I	650±10	5.2	3.5

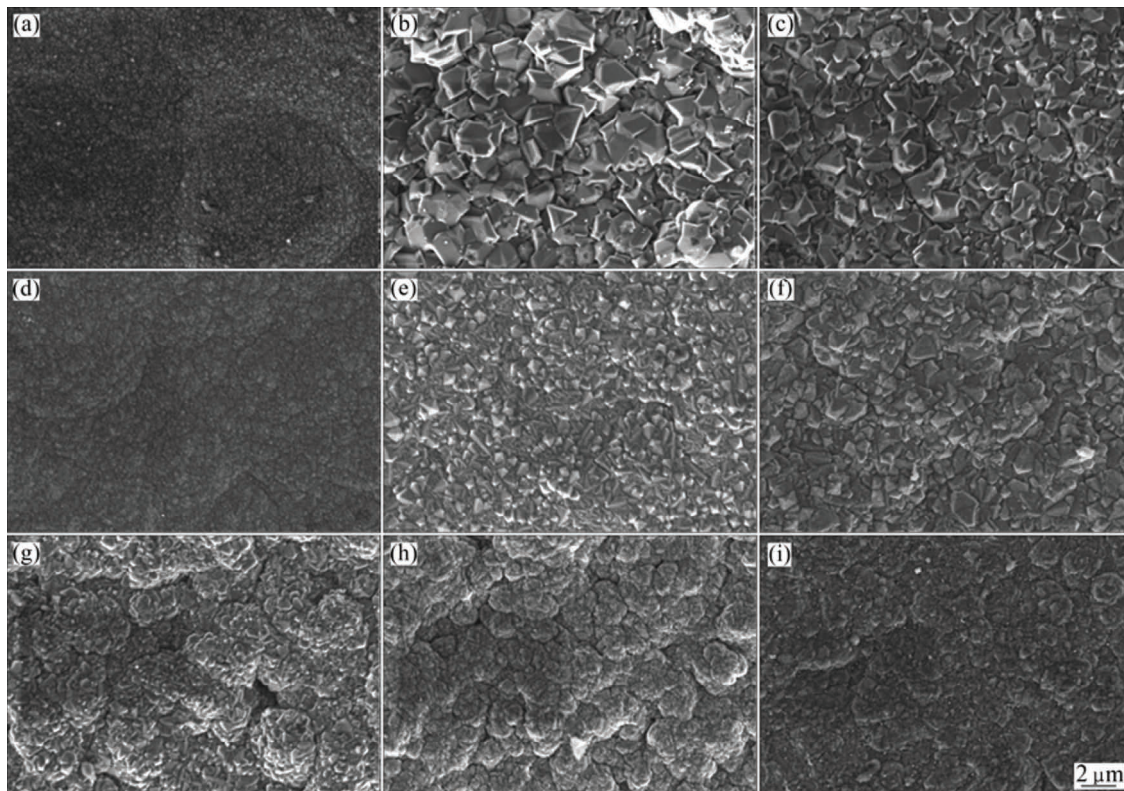
with He–Ne laser ( $\lambda=632.8\text{ nm}$ ). Moreover, the Rockwell indentation tests were conducted to assess the adhesive strength between the diamond film and substrate with a load of 980 N at the diamond indenter.

### 3 Results and discussion

#### 3.1 Surface morphology

The surface morphologies of diamond films deposited under different conditions are shown in Fig. 2. The surface morphology of the diamond films in the present study is mainly defined as the grain size, which can be distinguished into three levels: micro-crystalline, sub-microcrystalline and nano-crystalline. The ball-like

morphologies with structures made up of nano-crystalline grains are presented in Figs. 2(a) and (d) under the conditions of  $p=1.3\text{ kPa}$ ,  $t=930\text{ }^{\circ}\text{C}$  and  $p=1.3\text{ kPa}$ ,  $t=810\text{ }^{\circ}\text{C}$ . On the contrary, pyramidal features of the diamond particles are observed in Figs. 2(b), (c) and (e)–(g). Besides, the grain sizes of the diamond films deposited at higher temperatures (Figs. 2(b) and (c)) are significantly larger than those at lower temperatures (Figs. 2(e)–(g)). Figures 2(b) and (c) show the dense and homogeneous well-faceted polycrystalline diamond films with particle size of  $\sim 1.5\text{ }\mu\text{m}$  at  $930\text{ }^{\circ}\text{C}$ . In Fig. 2(e), the surface morphology becomes discontinuous at  $810\text{ }^{\circ}\text{C}$  and the large clusters made up of fine grains are obvious. However, the surface of the sample F (Fig. 2(f)) is also dense, due to the high total pressure (5.2 kPa). It is noted that the diamond films in Fig. 2(g) display pyramid-like structures but not ball-like morphologies, which are different from samples A and D at the same total pressure, possibly due to the comprehensive effects of the high carbon content (5%, volume fraction) and lower substrate temperature. Moreover, the agglomerations of diamond films with sub-microcrystalline particles are observed from Figs. 2(h) and (i). The surface morphology is determined by the appearance of crystal facets and crystallographic orientation, which is expressed by the  $\alpha$  parameter [23]. The  $\alpha$  parameter mainly depends on the deposition parameters [24]. The domains of (100) and (111)



**Fig. 2** SEM images of samples: (a) Sample A; (b) Sample B; (c) Sample C; (d) Sample D; (e) Sample E; (f) Sample F; (g) Sample G; (h) Sample H; (i) Sample I



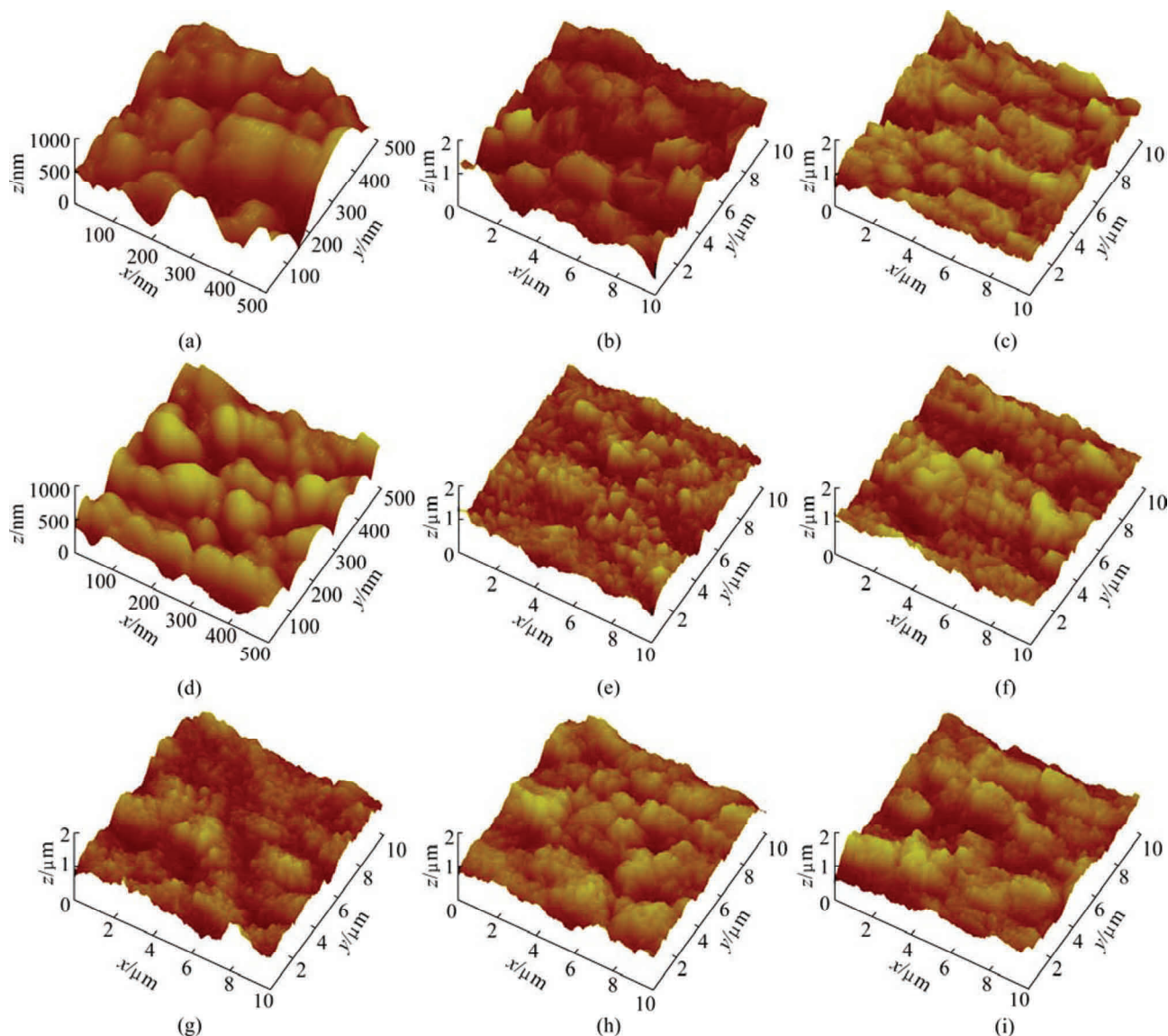
oriented growth of diamond films of all the samples (except samples A and D) are grown at the condition of  $\alpha > 3$  [25,26]. For samples A and D, the ball-like structures are attributed to the non-diamond phases nucleating on both (111) and (100) faces under the condition of  $2 < \alpha < 3$  [27].

The corresponding AFM images of as-deposited diamond films are shown in Fig. 3. In order to identify the grain size of different diamond films, the scanning area for nano-crystalline diamond films (Figs. 3(a) and 3(d)) is  $0.5 \mu\text{m} \times 0.5 \mu\text{m}$ , and that for the others is  $10 \mu\text{m} \times 10 \mu\text{m}$ . The average grain sizes of all the samples are listed in Table 2. Overall, the diamond films deposited at  $930^\circ\text{C}$  and  $810^\circ\text{C}$  present well-faceted pyramidal features, while the film deposited at  $650^\circ\text{C}$  shows cluster shapes consisting of fine grains. It is noted that there are many valley areas between the clusters, indicating the poor density of the surfaces. The results

suggest that the total pressure has the most notable effect on the grain size, followed by the substrate temperature.

### 3.2 Growth rate

In order to investigate the growth rate, the samples are cut off by electric discharge machining. The film thickness is measured according to the cross-sectional morphologies, as shown in Fig. 4. The approximate growth rates are listed in Table 2, which range from  $\sim 0.2$  to  $\sim 3.03 \mu\text{m/h}$ . At the pressure of 1.3 kPa, a relatively high growth rate is obtained with the higher substrate temperature. The nano-crystalline diamond films display the continuous growth of nanostructure diamond, as shown in Figs. 4(a) and (d). Furthermore, in the cases of 3.9 kPa and 5.2 kPa, the growth rate increases with the increment of substrate temperature and carbon content. It can be concluded that the total pressure has the most significant impact on the growth rate.



**Fig. 3** AFM image of samples: (a) Sample A; (b) Sample B; (c) Sample C; (d) Sample D; (e) Sample E; (f) Sample F; (g) Sample G; (h) Sample H; (i) Sample I

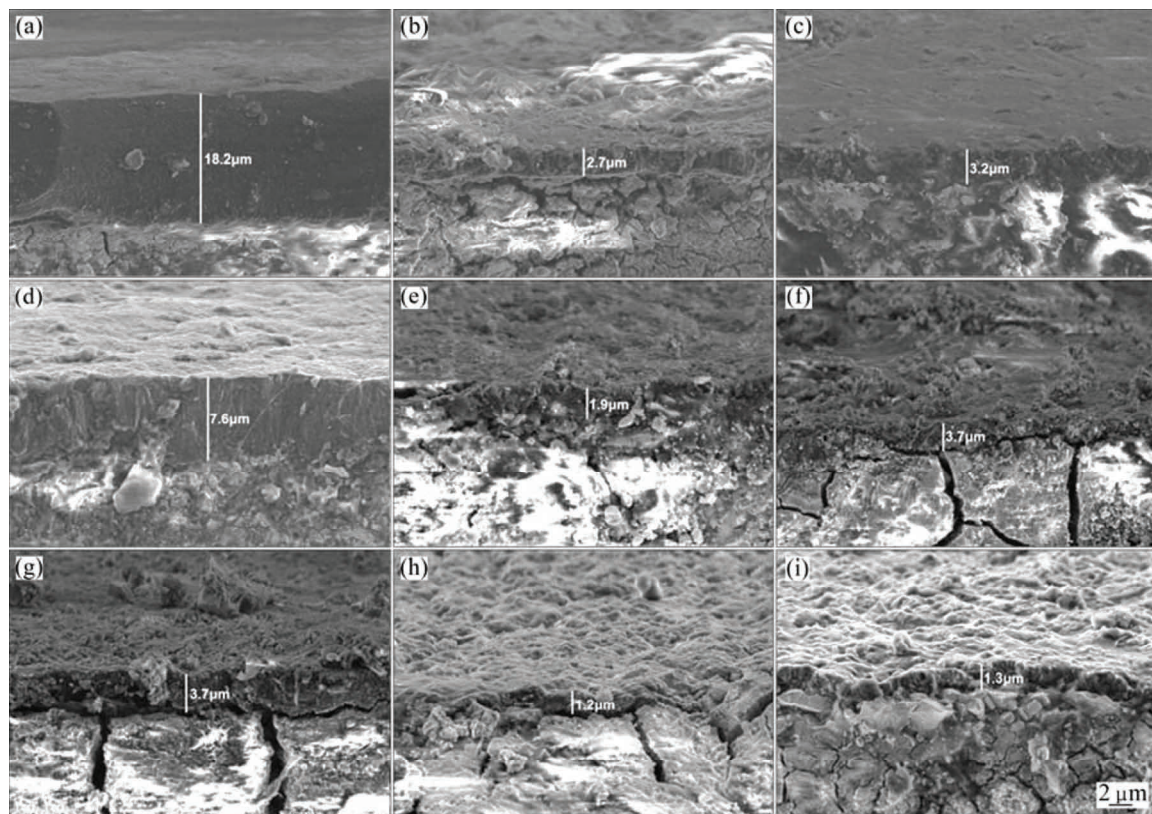
**Table 2** Average grain sizes, growth rate and figure of merit value

Sample No.	Average grain size/ nm	Growth rate/ ( $\mu\text{m}\cdot\text{h}^{-1}$ )	Figure of merit value/%
A	80	3.03	36.9
B	1500	0.45	69.9
C	1100	0.53	64.3
D	90	1.27	28.6
E	650	0.32	79.5
F	670	0.45	36.7
G	495	0.62	33.9
H	460	0.20	7.8
I	355	0.22	3.8

### 3.3 Raman spectroscopy analysis

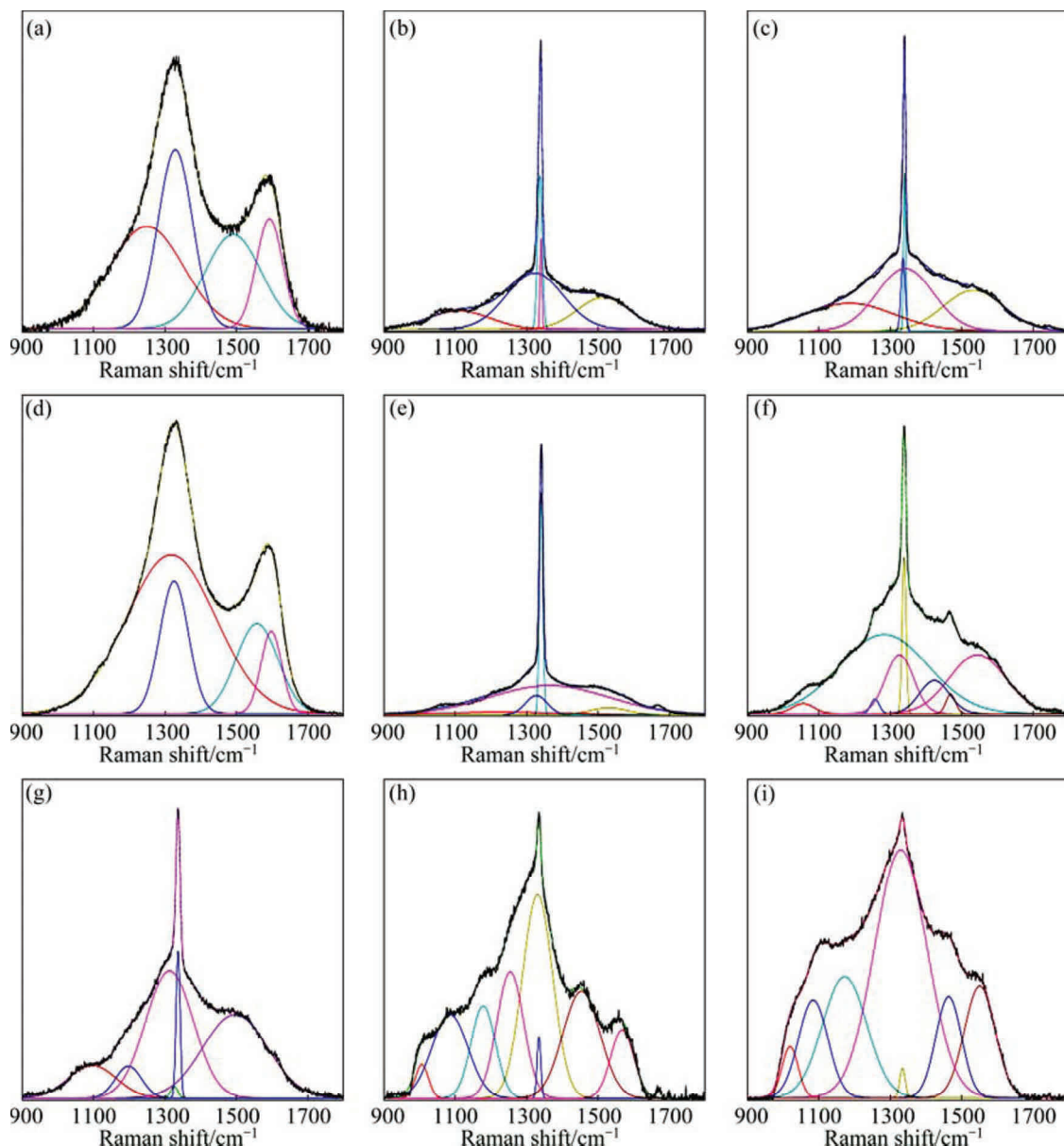
Raman spectroscopy is frequently used to characterize the CVD diamond films, giving the ability of being sensitive to the different carbon phases [28]. The Raman spectra of the diamond films deposited with different parameters are plotted in Fig. 5. In order to assess the effects of the deposition variables, the Raman spectra are all deconvoluted and analyzed by multi-Gaussian peak fitting. The diamond peak positions and FWHMs (full width at half maximum) observed for all samples are given in Table 3. The nano-crystalline diamond features are exhibited in Figs. 5(a) and (d), in

which the diamond position peaks are respectively at  $1328.3\text{ cm}^{-1}$  and  $1324.7\text{ cm}^{-1}$ . In Fig. 5(a), the presence of a broad feature at  $\sim 1250\text{ cm}^{-1}$  is ascribed to the amorphous  $\text{sp}^3$ -bonded carbon [29,30]. The bands at  $1490.6\text{ cm}^{-1}$  and  $1592.1\text{ cm}^{-1}$  are corresponding to the trans-polyacetylene and graphite ( $\text{sp}^2$ ) structure [31,32]. For sample B, the typical  $\text{sp}^3$  diamond peak shifts from its normal position at  $1332\text{ cm}^{-1}$  and splits into two components (doublet phonon at higher frequency of  $1340.5\text{ cm}^{-1}$  and singlet phonon at lower frequency of  $1337.5\text{ cm}^{-1}$ ), which is resulted from the large compressive residual stress presented in the films [33]. The Raman spectrum of sample C is similar to that of sample B, with two bands at  $1336.7\text{ cm}^{-1}$  and  $1341.1\text{ cm}^{-1}$  for diamond peaks, indicating that the higher substrate temperature will lead to higher residual stresses. From Figs. 5(e) to (i), it can be observed that the non-diamond phases increase as the temperature decreases. The figure of merit value ( $Q$ ) for the amount of diamond in the deposition is calculated by the ratio of  $I_D/(I_D+I_C)$ , where  $I_D$  is the integrated intensity of diamond peak and  $I_C$  is the integrated intensity of the non-diamond carbon [34]. It can be noticed that the most notable influencing factor on the structural quality of the diamond films is the substrate temperature, manifesting that the higher  $t$  will lead to higher  $Q$ , suggesting the better quality.



**Fig. 4** SEM images of fracture cross-section of samples: (a) Sample A; (b) Sample B; (c) Sample C; (d) Sample D; (e) Sample E; (f) Sample F; (g) Sample G; (h) Sample H; (i) Sample I





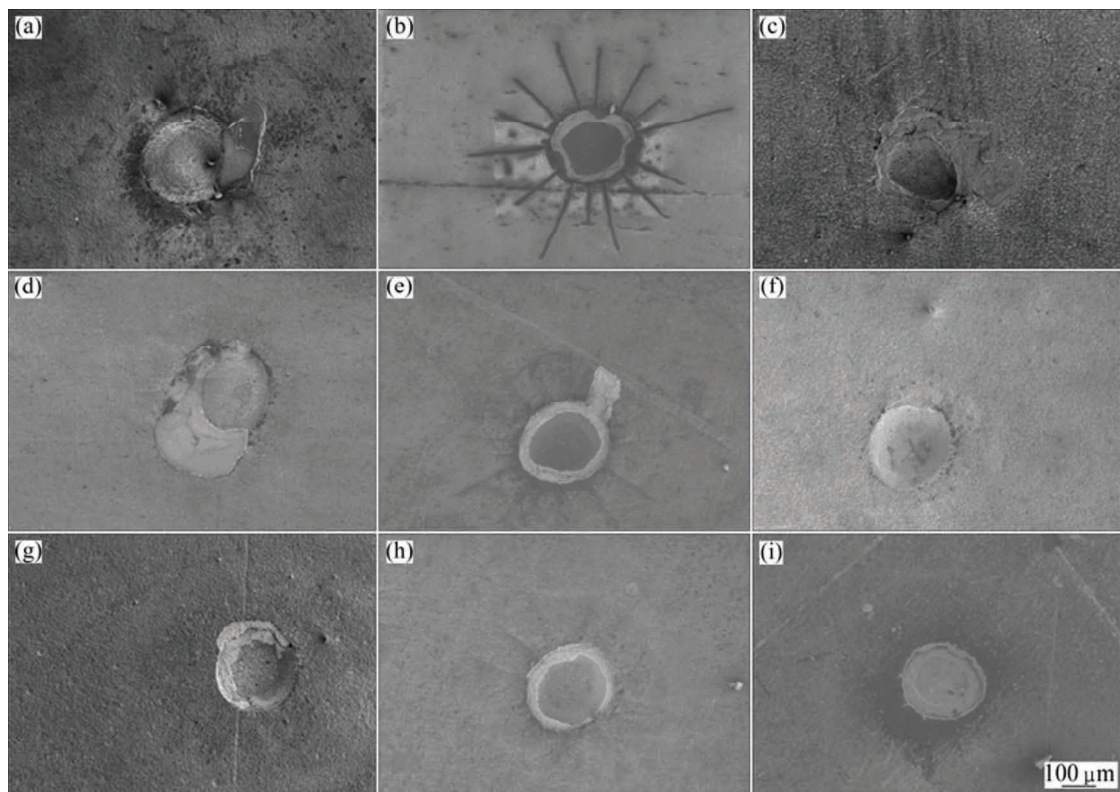
**Fig. 5** Raman spectra of diamond films of samples: (a) Sample A; (b) Sample B; (c) Sample C; (d) Sample D; (e) Sample E; (f) Sample F; (g) Sample G; (h) Sample H; (i) Sample I

**Table 3** Peak position and FWHM of diamond

Sample No.	Diamond peak position/cm <sup>-1</sup>	FWHM/cm <sup>-1</sup>
A	1328.3	48.2
B	1337.5	6.6
	1340.5	2.7
C	1336.7	6.1
	1341.1	2.9
D	1324.7	39.9
E	1339.8	4.9
F	1338.6	5.4
G	1337.1	5.6
H	1334.1	5.3
I	1333.8	7.7

### 3.4 Adhesive strength

The SEM images of the indentations on the different samples are shown in Fig. 6. At 930 °C, flaking off of the films is obvious, as demonstrated in Figs. 6(a)–(c). The peeling area on sample C is larger than that on sample A. For sample B, there are many long cracks around the indentation imprint, which are attributed to the higher residual stress in the films induced by the higher temperature. With temperature decreasing from 810 to 650 °C, the peeling area becomes smaller. Besides, the adhesive strength is also associated with the film thickness. The samples deposited at 650 °C display good adhesion, mainly due to the small thickness. As to the nano-diamond films in Figs. 6(a) and (d), severer delamination occurs on the nano-crystalline films



**Fig. 6** SEM images of Rockwell indentations on diamond films of samples: (a) Sample A; (b) Sample B; (c) Sample C; (d) Sample D; (e) Sample E; (f) Sample F; (g) Sample G; (h) Sample H; (i) Sample I

with the thickness of 7.6  $\mu\text{m}$ , indicating that increasing film thickness will generally increase the resistance of film delamination [35].

## 4 Conclusions

1) The three-factor, three-level fractional factorial design experiments are conducted to investigate the effects of several key deposition parameters on the diamond films grown on WC–Co substrates by HFCVD method.

2) The substrate temperature is found to have notable effects on the diamond structural quality. The total pressure has the greatest impact on the grain size and growth rate while has the minimum influence on the structural quality.

3) In the range of carbon content used in this investigation, the carbon content has no significant effect on the grain size and growth rate. The lower total pressure (1.3 kPa) is beneficial to fabricating nano-diamond films. This study can be extended to fabricate high-quality diamond coated WC–Co tools with complex geometries.

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## 沉积参数对硬质合金基体微/纳米金刚石薄膜生长的影响

张建国, 王新昶, 沈 彬, 孙方宏

上海交通大学 机械与动力工程学院, 上海 200240

**摘 要:** 基体温度、反应压力和碳源浓度等沉积参数决定热丝化学气相沉积金刚石薄膜的性能。运用正交试验方法, 研究参数对硬质合金基体金刚石薄膜生长的综合作用。采用场发射扫描电镜(FE-SEM)、原子力显微镜(AFM)和拉曼(Raman)光谱检测薄膜的形貌结构、生长速率和成分。结果表明: 随着基体温度的降低, 金刚石形貌从锥形结构向团簇状结构转变; 低反应压力有利于纳米金刚石薄膜的生成; 生长速率受反应压力和碳源浓度综合作用的影响。

**关键词:** 热丝化学气相沉积; 金刚石薄膜; WC–Co 硬质合金基体; 沉积参数

(Edited by Xiang-qun LI)